Lecture 20

DIFFRACTION THEORY OF A LENS

We have previously seen that light passing through a lens experiences a phase delay given by:

$$\varphi(\xi, \eta) = \exp\left[-jk(n-1)\left(\frac{\xi^2 + \eta^2}{2}\right)\left(\frac{1}{R_1} - \frac{1}{R_2}\right)\right] \quad \text{(neglecting the constant phase)}$$

The focal length, f is given by:

$$\frac{1}{f} = (n-1)\left(\frac{1}{R_1} - \frac{1}{R_2}\right)$$
 The "lens makers formula"

The transmission function is now:

$$\varphi(\xi, \eta) = \exp\left[-j\frac{k}{2f}(\xi^2 + \eta^2)\right]$$

This is the paraxial approximation to the spherical phase

Note: the incident plane-wave is converted to a spherical wave converging to a point at f behind the lens (f positive) or diverging from the point at f in front of lens (f negative).

Diffraction from the lens pupil

Suppose the lens is illuminated by a plane wave, amplitude A. The lens "pupil function" is $P(\xi, \eta)$.

The full effect of the lens is $U'_{l}(\xi, \eta) = \varphi(\xi, \eta)P(\xi, \eta)$

$$U_l'(\xi,\eta) = P(\xi,\eta) \exp\left[-j\frac{k}{2f}(\xi^2 + \eta^2)\right]$$

We now use the Fresnel formula to find the amplitude at the "back focal plane" z = f

$$U_{f}(x,y) = \frac{\exp\left[j\frac{k}{2f}(x^{2}+y^{2})\right]}{j\lambda f} \times e^{jkf} \int_{-\infty}^{\infty} d\xi d\eta U_{l}'(\xi,\eta) \exp\left[j\frac{k}{2f}(\xi^{2}+\eta^{2})\right] \exp\left[-j\frac{2\pi}{\lambda f}(\xi x+\eta y)\right]$$

The phase terms that are quadratic in $\xi^2+\eta^2$ cancel each other.

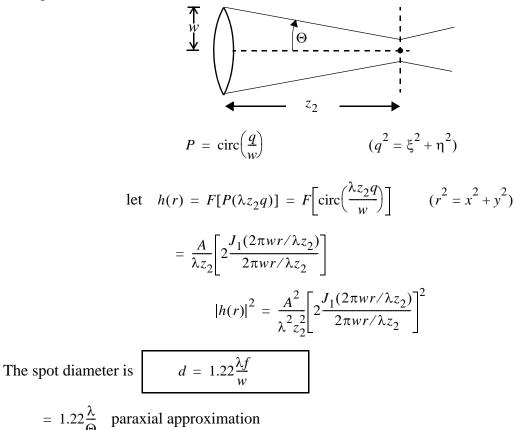
$$U_{f}(x,y) = \frac{\exp\left[j\frac{k}{2f}(x^{2}+y^{2})\right]}{j\lambda f}e^{jkf}\int_{-\infty}^{\infty}d\xi d\eta P(\xi,\eta)\exp\left[-j\frac{2\pi}{\lambda f}(\xi x+\eta y)\right]$$
(A)

This is precisely the Fraunhofer diffraction pattern of P! Note that a large z criterion *does not* apply here.

The focal plane amplitude distribution is a Fourier transform of the lens pupil function $P(\xi, \eta)$, multiplied by a quadratic phase term. However, the intensity distribution is exactly

$$I_{f}(x, y) = \frac{A^{2}}{\lambda^{2} f^{2}} |F[P(\xi, \eta)]|^{2} \qquad f_{x} = \frac{x}{\lambda f}$$
$$f_{y} = \frac{y}{\lambda f}$$

Example: a circular lens, with radius w



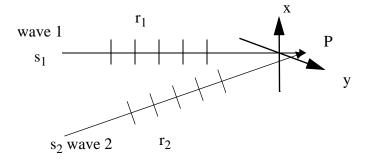
The "Rayleigh" resolution of the lens is $d/2 = 0.66\lambda/\Theta$.

For a large
$$\Theta$$
, $d/2 = 0.61 \frac{\lambda}{\sin \Theta} = 0.61 \frac{\lambda}{NA}$

INTERFERENCE

[Reading assignment: Hecht 9.1, 9.3 (to p. 396 only), 9.4, 9.7.2, 9.8.2, 9.8.3]

Interference occurs when light from different sources or different paths are superimposed. As an electromagnetic wave, when two waves superimpose, it is the electric field <u>amplitudes</u> that <u>add</u>.



Let the two sources radiate plane waves so that

$$E_1 = A_1 \cos\left(\omega_1 t - \frac{2\pi r_1}{\lambda_1} + \phi_1\right) = A_1 \cos(\omega_1 t + \alpha_1)$$
$$E_2 = A_2 \cos\left(\omega_2 t - \frac{2\pi r_2}{\lambda_2} + \phi_2\right) = A_2 \cos(\omega_2 t + \alpha_2)$$

At P, we add the fields

$$E(P) = E_1 + E_2$$

The intensity is generally what is detected

$$I(P) = \langle |E_1 + E_2|^2 \rangle$$

where the average is a time average over detector response time,

$$= \langle A_1^2 \cos^2(\omega_1 t + \alpha_1) + A_2^2 \cos^2(\omega_2 t + \alpha_2) \\ + A_1 A_2 \cos[(\omega_1 + \omega_2)t + (\alpha_1 + \alpha_2)] + A_1 A_2 \cos[(\omega_1 - \omega_2)t + (\alpha_1 - \alpha_2)] \rangle$$

When $\omega_1 \neq \omega_2$, the $\cos(\omega_1 \pm \omega_2)t$ terms average out

$$I(P) = I_1 + I_2$$

If $\omega_1 = \omega_2 = \omega$, then we get an interference:

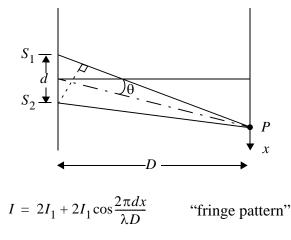
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$$\begin{split} I(P) &= I_1 + I_2 + \langle A_1 A_2 \cos[2\omega t + (\alpha_1 + \alpha_2)] + A_1 A_2 \cos(\alpha_1 - \alpha_2) \rangle \\ &= I_1 + I_2 + 2\sqrt{I_1 I_2} \cos(\alpha_1 - \alpha_2) \\ &= I_1 + I_2 + 2\sqrt{I_1 I_2} \cos\left[\left(\frac{2\pi}{\lambda}\right)((r_1 - r_2) + (\phi_1 - \phi_2))\right] \end{split}$$

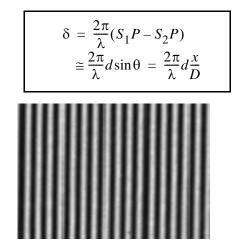
interference term

The intensity observed shows maxima + minima as the *path length difference* $(r_1 - r_2)$ varies [assumes phase factors do not vary (ϕ_1, ϕ_2)] This gives rise to constructive and destructive interference. The phase difference is $\delta = \frac{2\pi}{\lambda}(r_1 - r_2)$.

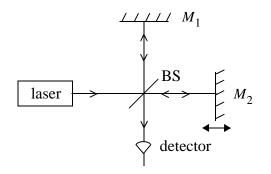
Young's two-slit interference experiment



Phase difference



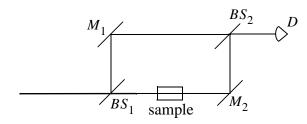
Michelson interferometer



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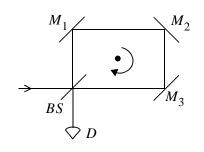
Used for distance measuring. As M_2 moves, we count cycles using the detector. With good S/N ratio and a stable laser, movement as small as $\lambda/1000$ (~ 5A°!) can be measured. Large movement can be measured with this accuracy. Such interferometers are very useful for very precise servo control of positioning systems.

Mach-Zender



This interferometer can be used for measuring material properties. If the index of refraction of the sample varies, then the phase difference varies and the intensity at D varies. As an example, one can determine the temperature dependence of the index of refraction n for air or other gases.

Sagnac interferometer (modified Mach-Zender)



If the interferometer is rotating clockwise, the clockwise light has a longer time-of-flight than the opposite direction.

of fringes shift
$$N = \frac{4A\Omega}{c\lambda}$$
 A: area
 Ω : rot vel

By using a spool of fiber instead of discrete mirrors, a very stable arrangement can be made and sensitivity is increased by n, the number of turns of fiber on the spool. This is called the "fiber-ring gyro," very popular in inertial navigation.